

The Use of Spreadsheets in Packaging Thermal Calculations

**Tutorial
Semitherm-XIV
San Diego**

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Outline

Overview

Analytical formulas for 1-D and 2-D heat flow

- Conduction
- Conduction + constant heat transfer coefficient

Package environment

- Representation of test board
- Calculation of heat transfer coefficient

Thermal resistance network

- Numerical solution: non-linear boundary conditions

Spreadsheet structure

Case studies

Summary and Conclusions



Examples of Plastic Packages

MQFP



SuperBGA®



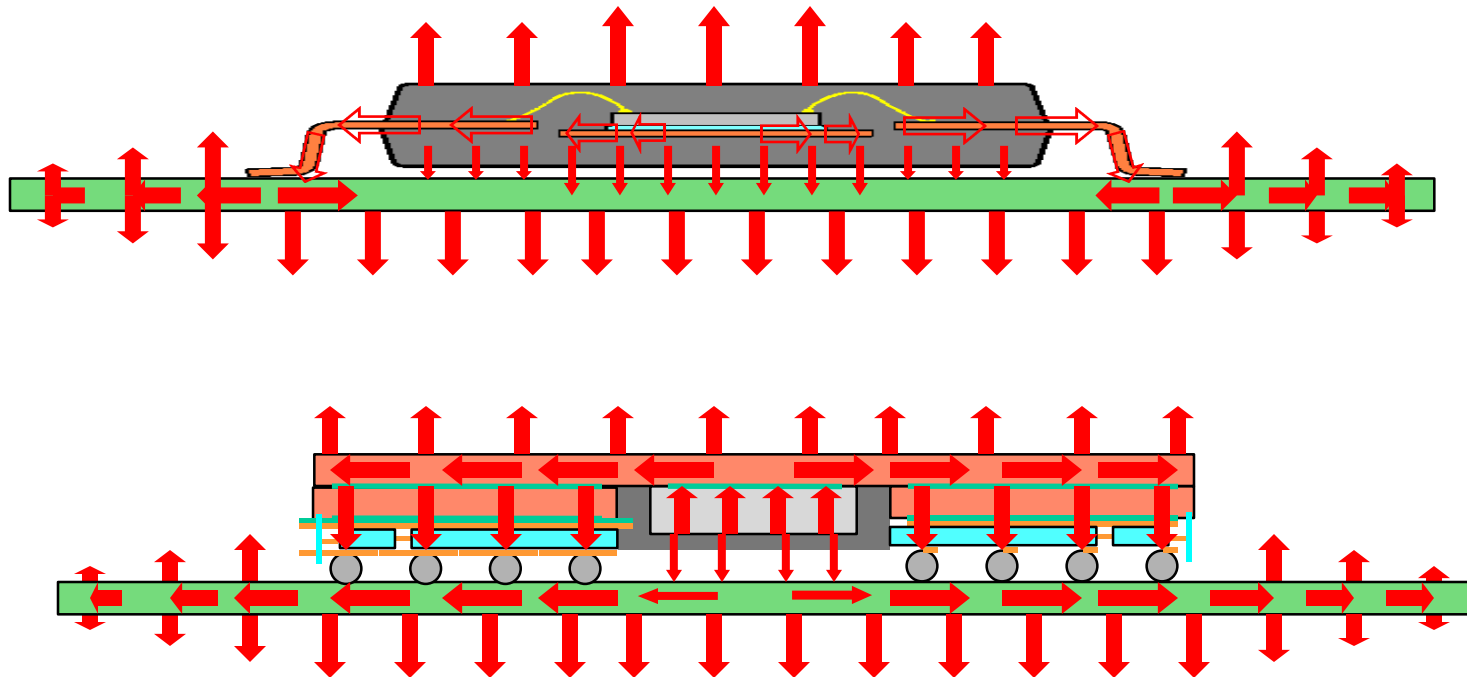
Layered structures

- High conductivity metals
- Low conductivity dielectrics
- Lateral dimensions much greater than thickness

Heat Flow in Plastic Packages

Heat Flow Patterns

- In-plane flow in metals
- Thru-plane flow in dielectrics



Approach to Analytical Modeling

In plastic packages, complicated heat flow patterns can be reduced to a series of heat flow building blocks that can be arranged in a thermal circuit diagram



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Definition of Thermal Resistance

$$\Theta = \frac{T_A - T_B}{P_{AB}}$$

T_A, T_B = Temperatures of isothermal surfaces

P_{AB} = Total thermal energy flowing between these surfaces per unit time

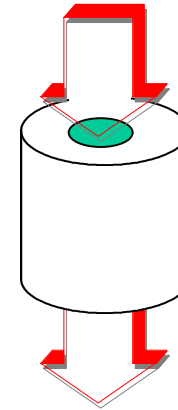
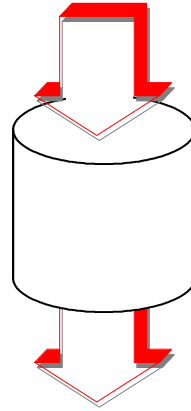
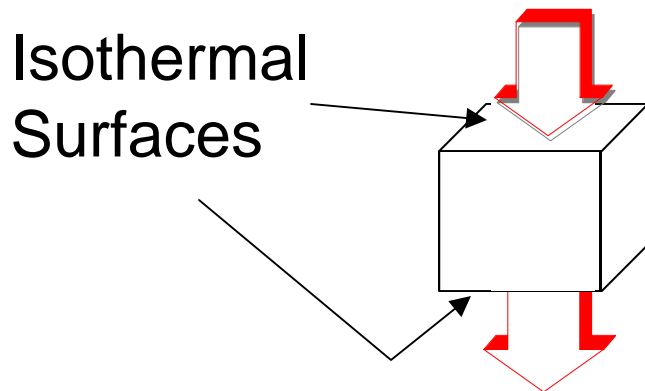


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1-Dimensional Heat Flow



t

Examples: **Die**
Die Attach

Bond Wire

Via

$$\Theta = \frac{t}{k A}$$

Block

$$A = L \times W$$

Cylinder

$$A = \pi r^2$$

Hollow Cylinder

$$A = \pi \times (r_{Outer}^2 - r_{Inner}^2)$$

A = Cross-Sectional Area

κ = Thermal Conductivity



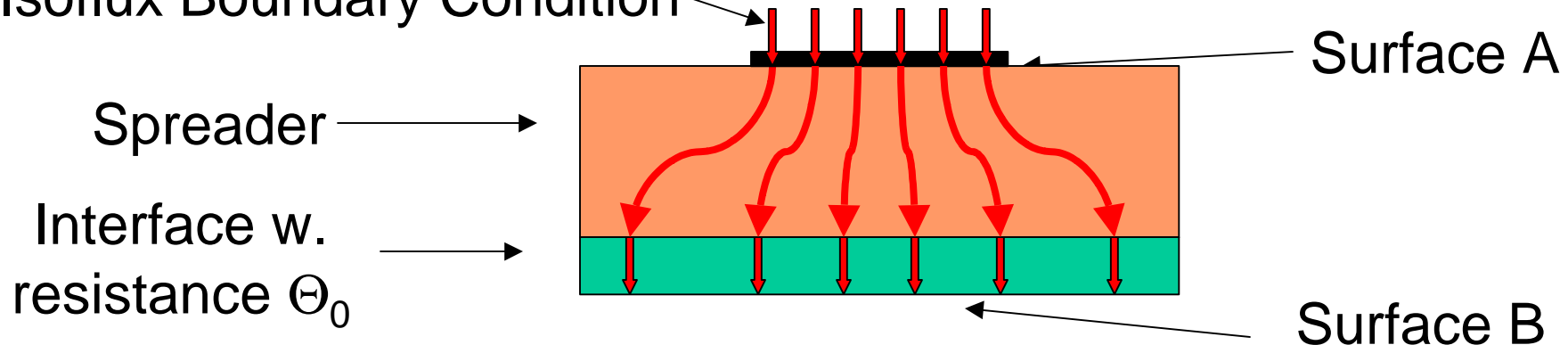
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1-Dimensional Heat Flow with Spreading Resistance Correction

Isoflux Boundary Condition



$$\Theta_{AB} = \Theta_{SPR} + \Theta_{SPREADER,1-D} + \Theta_0$$

Where:

$$\Theta_{SPR} = \frac{\sqrt{A_{SPR}} - \sqrt{A_{SOURCE}}}{k_{SPR} \sqrt{p} \sqrt{A_{SPR} A_{SOURCE}}} \times \frac{lk_{SPR} A_{SOURCE} \Theta_0 + \tanh(l t_{SPR})}{1 + lk_{SPR} A_{SPR} \Theta_0 \tanh(l t_{SPR})}$$

Θ_0 = Boundary or Conduction Thermal Resistance, and

$$l = \frac{p^{3/2}}{\sqrt{A_{SOURCE}}} + \frac{1}{\sqrt{A_{SPR}}}$$

[Ref: Seri Lee, "Calculation Spreading Resistance in Heat Sinks," Electronics Cooling Magazine, Vol. 4, No. 1 (Jan., 1998), pp. 30 - 33]

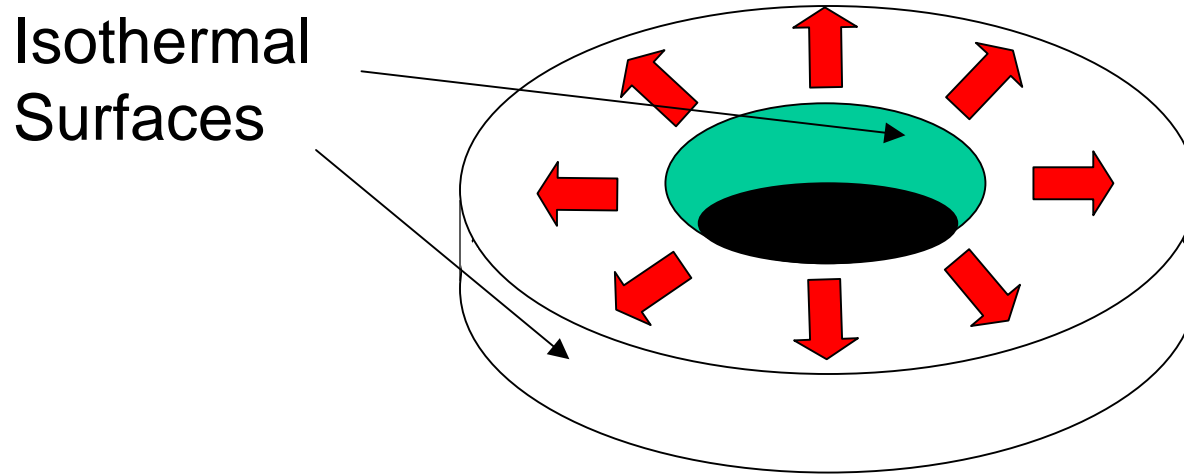


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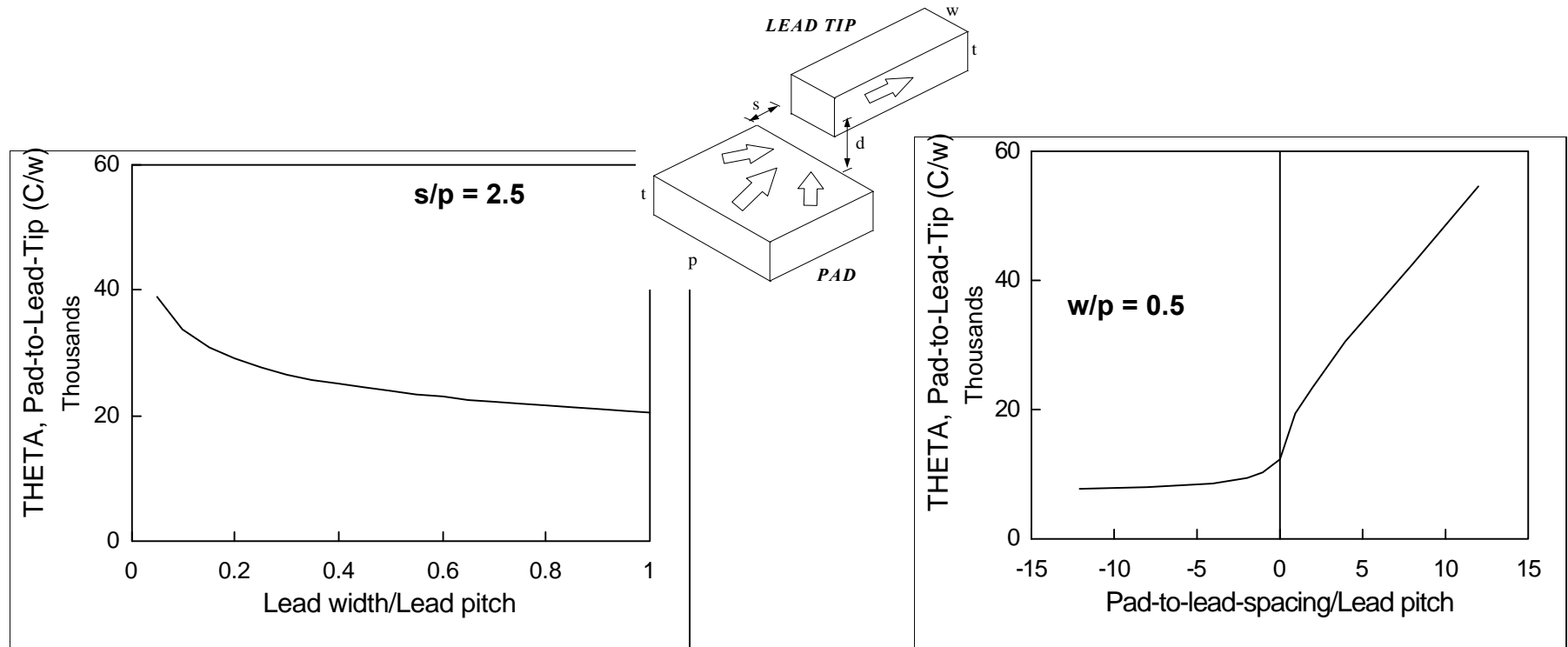
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2-Dimensional Heat Flow



$$\Theta = \frac{1}{2\pi k t} \ln \left(\frac{r_{OUT}}{r_{IN}} \right)$$

FEA Solution: Pad-to-Lead Thermal Resistance



(a) Dependence on w/p

(b) Dependence on s/p

L/F thickness=0.15 mm, $d=0.2$ mm, $p = 0.25$,
 $k(m/c)=0.6$ w/m-K, $k(L/F)=390$ w/m-K

[**Reference** B. S. Lall, B. M. Guenin, R. C. Marrs, and R. J. Molnar, "Parametric FEA Thermal Model for QFP Packages," *Proceedings, SEMI-THERM XII Conference*, March, 1996, pp. 105-110.]

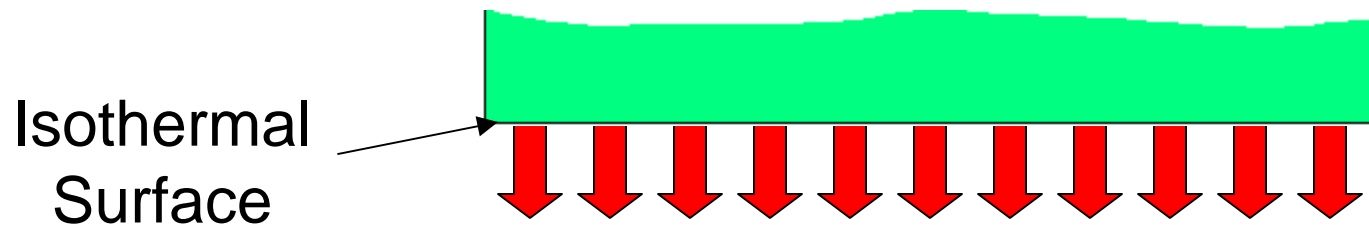


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Heat Transfer From Constant Temperature Surface

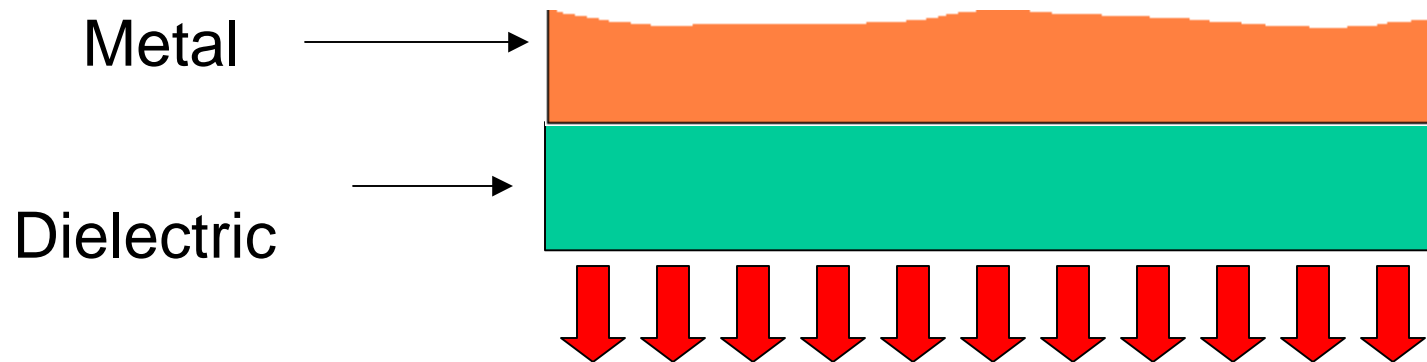


$$\Theta = \frac{1}{hA}$$

h = Heat Transfer Coefficient
 A = Surface Area

Heat Transfer to Ambient from Composite: Derating h

Temperature of metal may vary locally



$$h_{\text{EFF}} = \frac{hk_{\text{DIELECTRIC}}}{k_{\text{DIELECTRIC}} + ht_{\text{DIELECTRIC}}}$$



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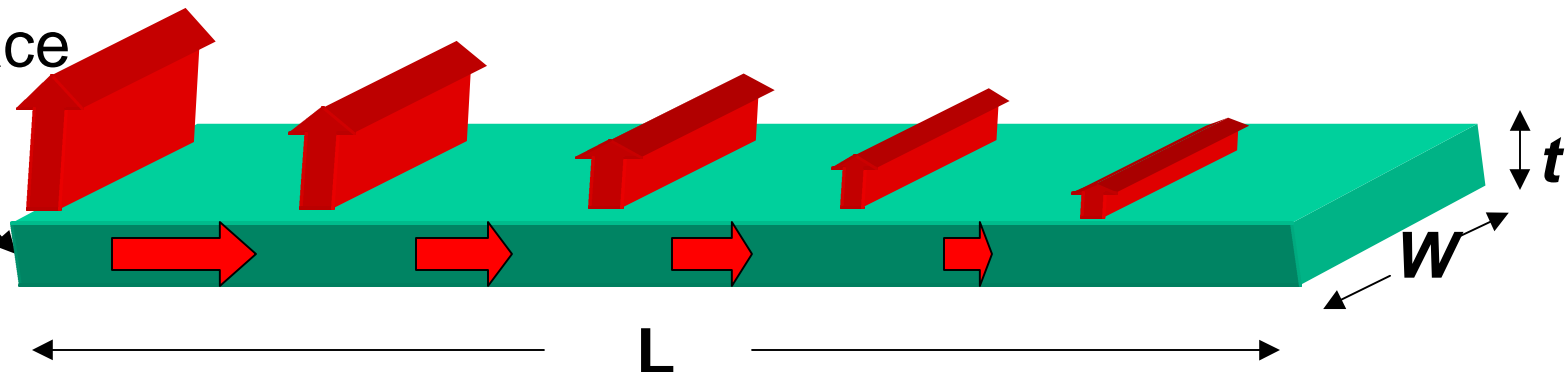
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1-D Distributed Conduction/ Convection/Radiation (Finite Fin)

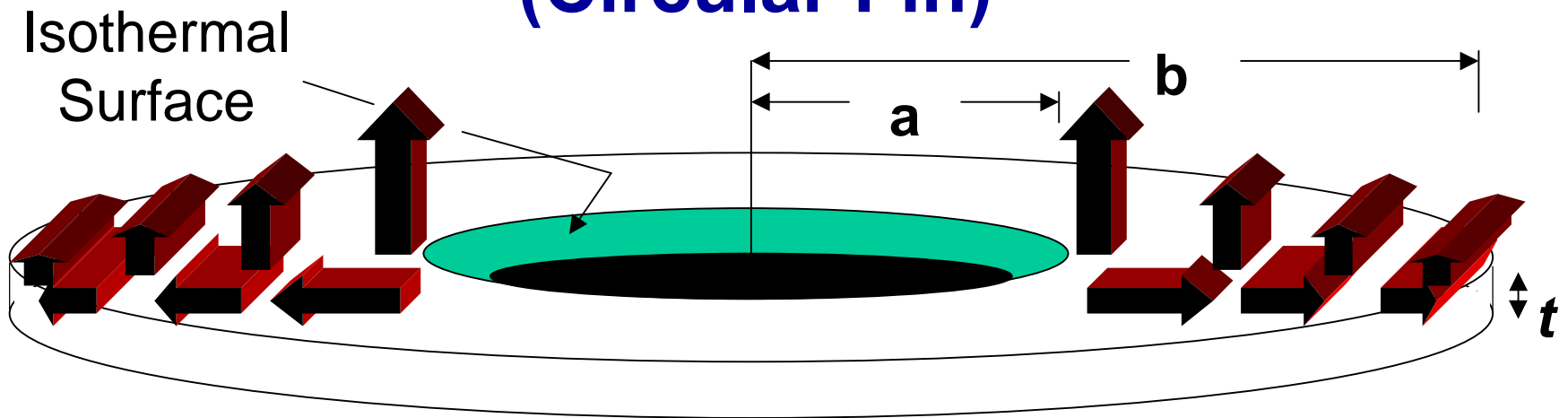
$$\Theta = \frac{a}{hW} \times \frac{e^{aL} + e^{-aL}}{e^{aL} - e^{-aL}}$$

$$a = (2h/k t)^{1/2} \quad [\text{For } h \text{ on both sides of fin}]$$

Isothermal
Surface



2-D Distributed Conduction/ Convection/Radiation (Circular Fin)



$$\Theta = \frac{1}{2\pi a k t \alpha} \left(\frac{K_1(a b) I_0(a a) + I_1(a b) K_0(a a)}{I_1(a a) K_1(a b) - I_1(a b) K_1(a a)} \right)$$

Where $\alpha = (2 h / k t)^{1/2}$ [For h on both sides of fin]

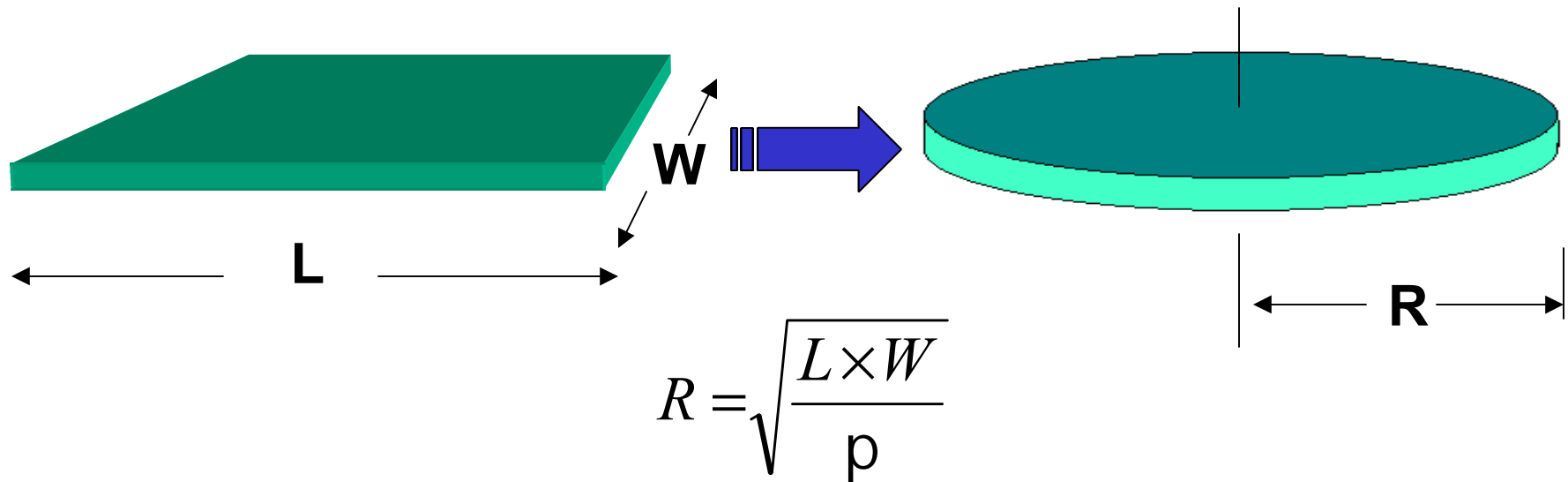
I_0 I_1 (K_0 , K_1): modified Bessel functions of the 1st (2nd) kind, order 0 and 1

Reference: B. M. Guenin, R. C. Marrs, and R. J. Molnar, "Analysis of a Thermally Enhanced Ball Grid Array Package," *IEEE Trans. Comp., Packaging, Manuf. Technol.* - Part A, Vol. 18, No. 4, December 1995, pp. 749-757.

2-D Heat Flow: Transform Rectangular to Circular Geometry

Transform rectangle into circle

- Equal area and thickness
- 1-D, 2-D, and Circular Fin problems [Ref.]



[Reference: B. Lall, A. Ortega, and H. Kabir, “Thermal Design Rules for Electronic Components on Conducting Boards in Passively Cooled Enclosures,” *Proceedings, Fourth InterSociety Conference on Thermal Phenomena in Electronic Systems*, May, 1994, pp. 50-61.]

Heat Transfer Coefficient

$$h_T = \left(h_{NC}^3(W, T) + h_{FC}^3(W, V_{AIR}) \right)^{1/3} + h_{RAD}(T)$$

h_T = Total Heat Transfer Coefficient

- Predicts heat loss to ambient in industry-standard windtunnel environment
- Deals with natural, mixed, and forced convection regimes
- Includes effect of radiation

References:

- 1) H. Shaukatullah, M.A. Gaynes, and L.H. White, "A Non-dimensional Correlation for the External Thermal Characteristics of Surface Mount Metal Quad Flat Packs," *Proceedings of the 4th Intersociety Conference on Thermal Phenomena in Electronic Systems*, 1994, pp. 237-244.
- 2) B. M. Guenin, A. Chowdhury, R. Groover, and E. J. Derian, "Analysis of Thermally-Enhanced SOIC Packages," *Proceedings, SEMI-THERM XII Conference*, March, 1996, pp. 1-13.



Heat Transfer Coefficient (Cont.)

$$h_{NC} = 8.66 \left(\frac{\Delta T_{Surface\ Air} (^{\circ}C)}{D_{CHAR} (mm)} \right)^{0.25} W / m^2^{\circ}C$$

$$h_{FC} = 119.9 \left(\frac{V_{AIR} (m / s)}{D_{CHAR} (mm)} \right)^{0.5} W / m^2^{\circ}C$$

$$h_{RAD} = 5.67 \times 10^{-8} e \left(\frac{T_{Surface}^4 (K^4) - T_{Air}^4 (K^4)}{T_{Surface} (K) - T_{Air} (K)} \right) W / m^2^{\circ}C$$

Assumes simple, standard package, board configuration

- Single package mounted centrally on test board
- h_{NC} and h_{FC} are area averages

h_{NC} assumes horizontal board orientation

D_{CHAR} = Characteristic Dimension

- Set equal to package width in direction of air flow

References:

h_{FC} : G.N. Ellison, *Thermal Computations for Electronic Equipment*, Krieger Publishing, Malabar, Florida, 1989.

h_{NC} : B. S. Lall, B. M. Guenin, R. C. Marrs, and R. J. Molnar, "Parametric FEA Thermal Model for QFP Packages," *Proceedings, SEMI-THERM XII Conference*, March, 1996, pp. 105-110.



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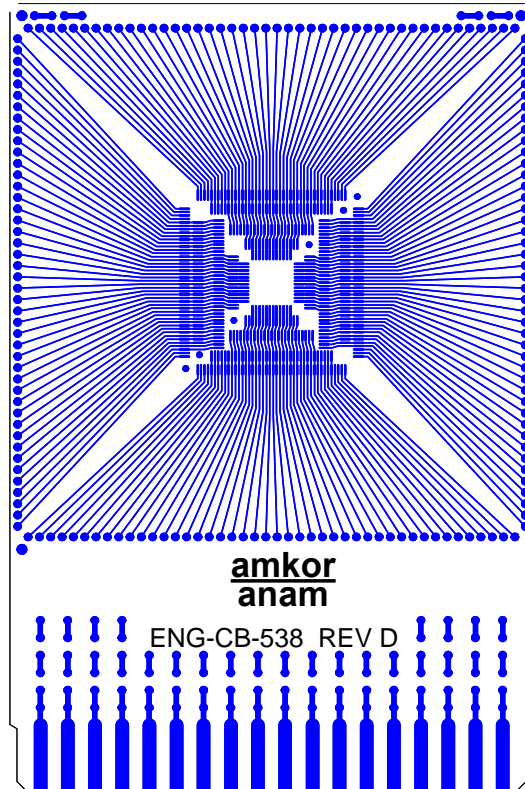
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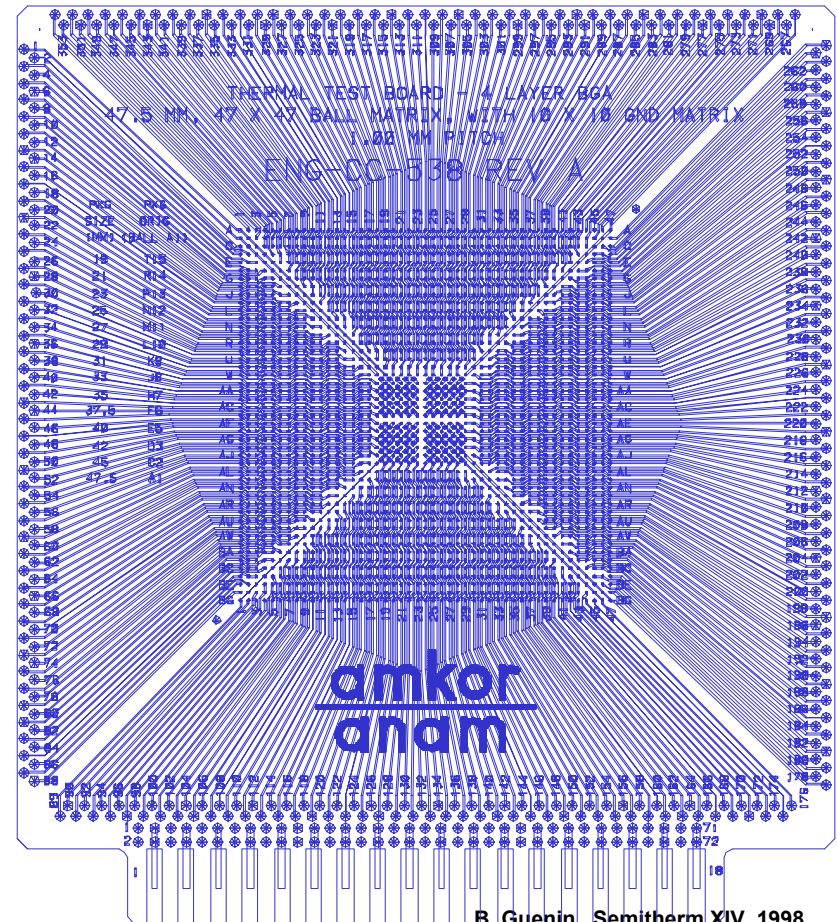
Examples of JEDEC-Standard Thermal Test Boards

Both boards shown are nested designs, to accommodate a variety of package sizes

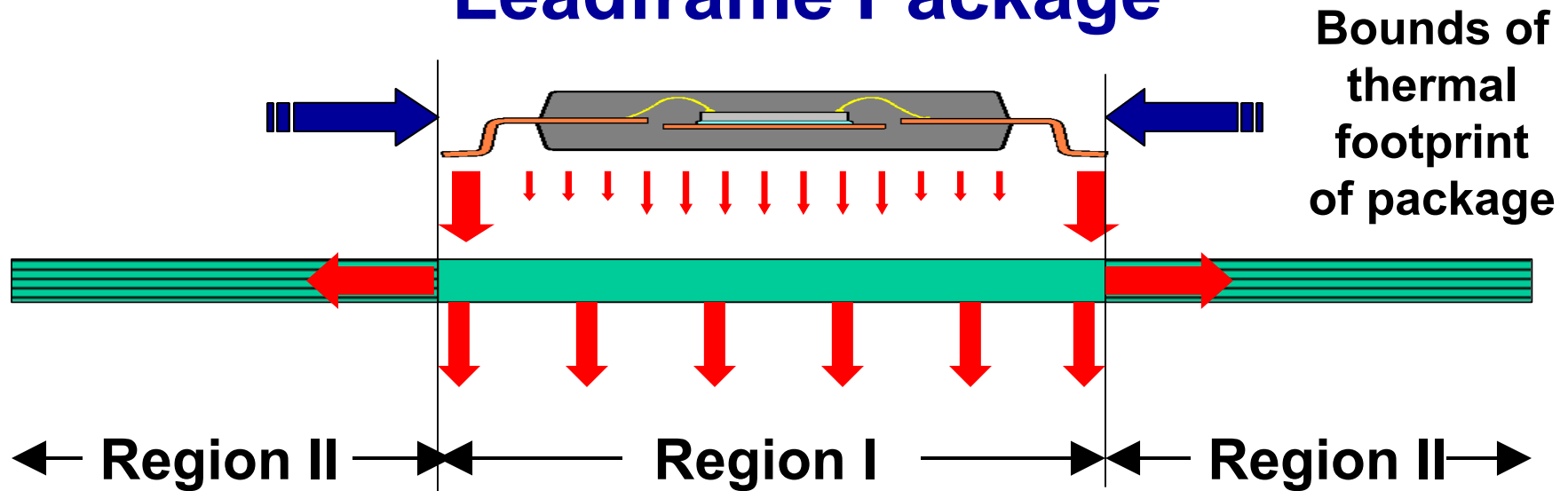
MQFP



BGA



Representation of Test Board: Leadframe Package



Region I represented as a *Control Volume*

- No internal thermal gradients
- Transmits heat to convective surface under footprint and to Region II

Region II represented as

- A circular fin (for boards containing internal planes)
- 4 parallel finite fins (for single-layer test boards)

Reference: B. M. Guenin and D. Mahulikar, "Methodology for the Thermal Characterization of the MQUAD[®] Microelectronic Package," *Proceedings, SEMI-THERM IX Conference*, February, 1993, pp. 176-185.

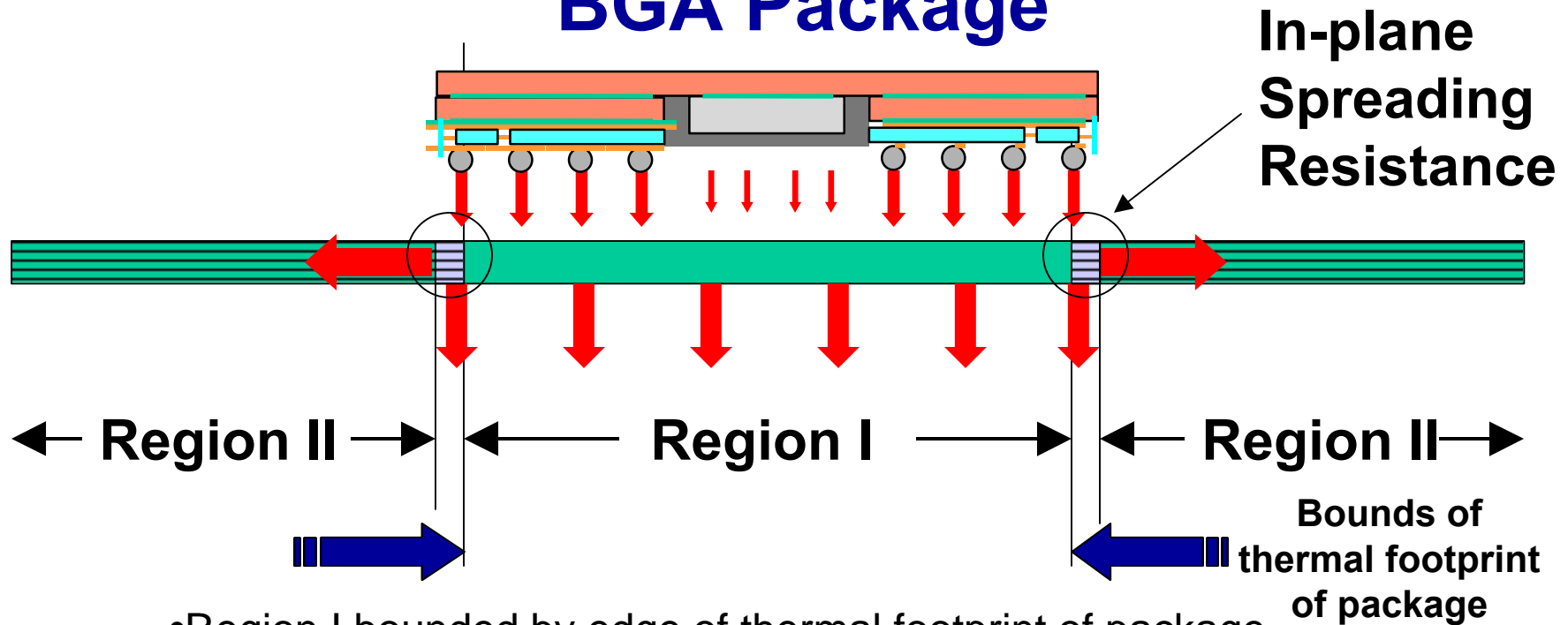


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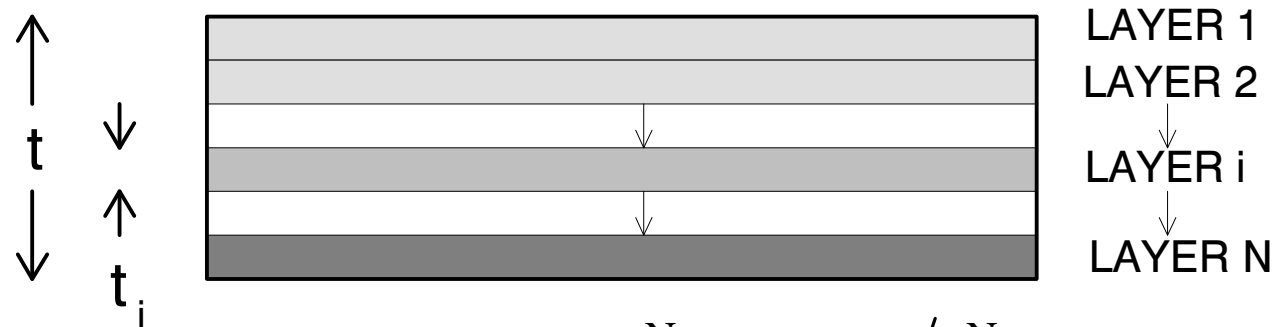
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Representation of Test Board: BGA Package



- Region I bounded by edge of thermal footprint of package
- Region II bounded by edge of package
- When thermal footprint < package width, in in-plane spreading resistance is placed in series with heat flow from Region I to II.
- Functional form of spreading resistance depends on board construction:
 - 2-D circular heat flow (for boards containing internal planes)
 - 4 parallel 1-D heat flow paths (for single-layer test boards)

Calculating Thermal Conductivity of Test Board



$$k_{\text{EFF-IN PLANE}} = \frac{\sum_{i=1}^N f_i k_i t_i}{\sum_{i=1}^N t_i}$$

f_i is the fractional coverage of copper in layer i

κ_i and t_i - thermal conductivity and thickness

For application boards, only include planes in calculation [Ref.]

Reference: K. Azar and J.E. Graebner, "Experimental Determination of the Thermal Conductivity of Printed Wiring Boards," *Proceedings, SEMI-THERM XII Conference*, March, 1996, pp. 169-182.



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Definition of a Spreadsheet

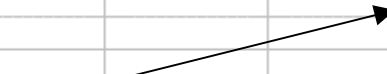
Mathematical, financial, engineering software

- Table structure
- Cells can contain
 - Text
 - Numbers
 - Formulas
- Formulas

Result is output in cell in which formula is located
Inputs come from other cells through linking

C	A	B	C	D	E	F	G	H
1	1-Dimensional Heat Flow Calculation							
2	COMPONENT	MAT'L	WIDTH	LENGTH	THICKNESS	TH.COND	Theta	
3			(mm)	(mm)	(mm)	(w/mm-°C)	(°C/W)	
4	Die	Si	12	12	0.61	0.092	0.91	
5								
6								
7								

+E4/(F4*C4*D4)



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Capabilities of Spreadsheets

Advanced mathematical and engineering functions

Macro (programming) languages

Graphing capabilities

Data table formatting



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Special Functions in Spreadsheets

Partial Listing (Lotus 5.0 and Excel 97)

- Bessel Functions, Std. And Modified 1st and 2nd Kind
- Beta and Incomplete Beta Function
- Error and Complementary Error Functions
- Gamma and Incomplete Gamma Function
- Exponential Function
- Natural Logarithm
- Common Logarithm (Base 10)
- Trig and Inverse Functions
- Hyperbolic Trig and Inverse Functions
- Complex Variable Analysis
- Statistical Functions

Additional Functions (Excel 97)

- Fast Fourier Transform



Motivation for Analytical Resistor Models

Promotes a high level of insight into how thermal performance of a package is related to its design

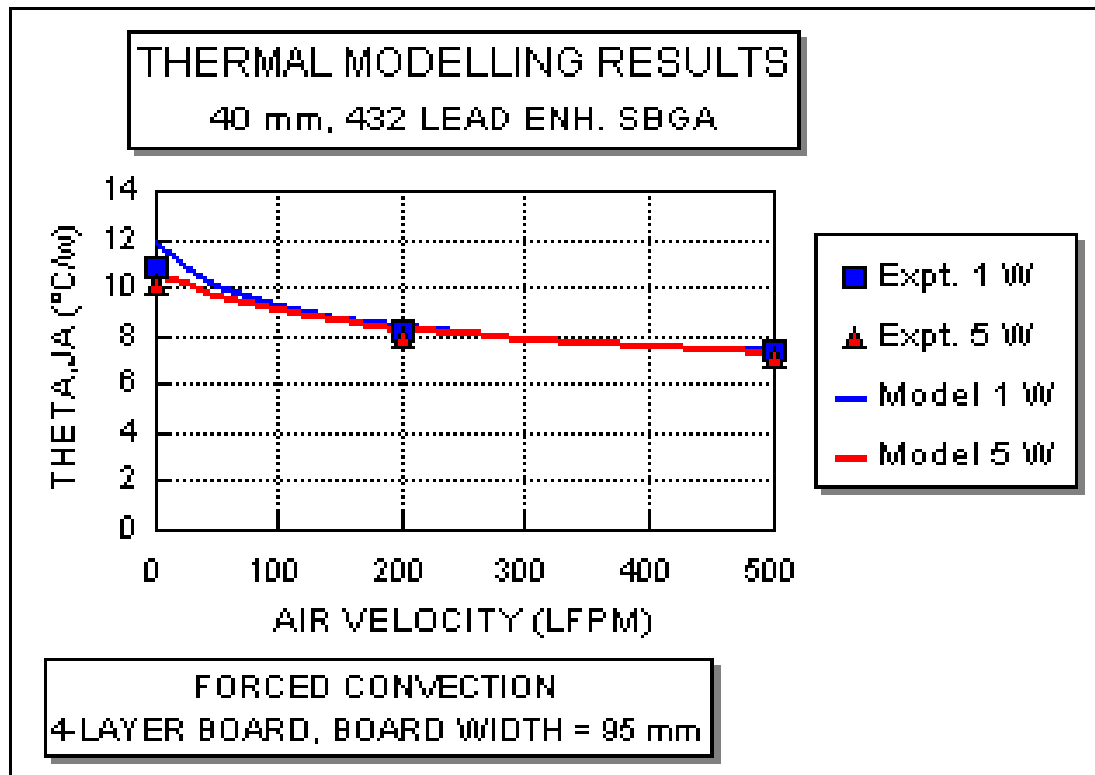
- Each package component individually represented in thermal circuit diagram

Can produce accurate, rapid solutions.

Readily incorporates non-linear boundary conditions.



Solution Accuracy



Model Curves

- 15 points each
- 10 sec/point
- Calculation completed in 5 min on 120 MHz Pentium

**Accurate solution in natural, mixed,
and forced convection regimes**

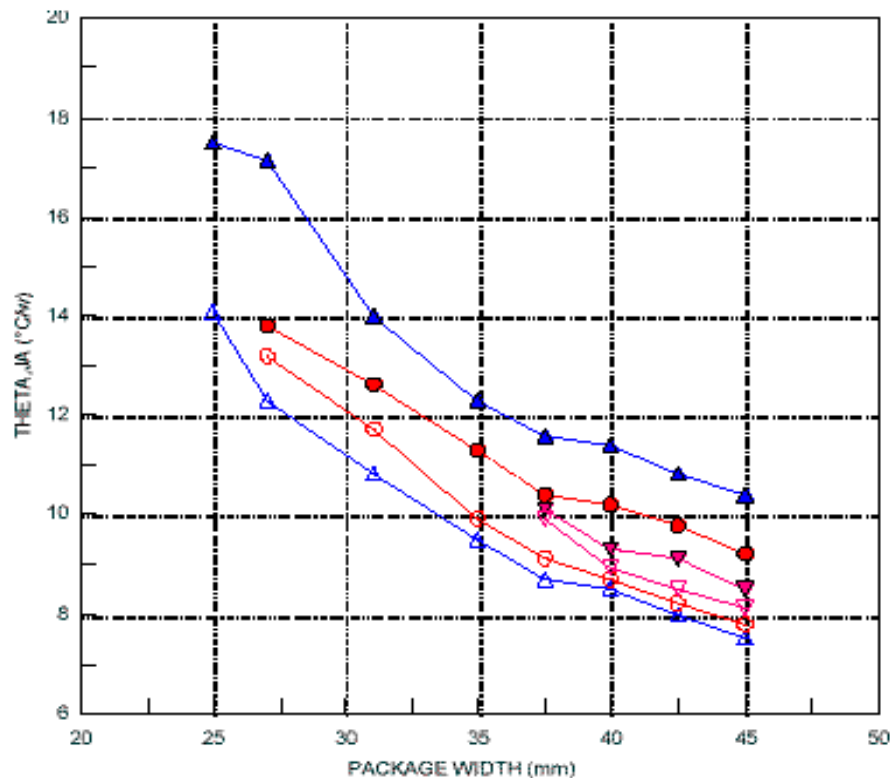


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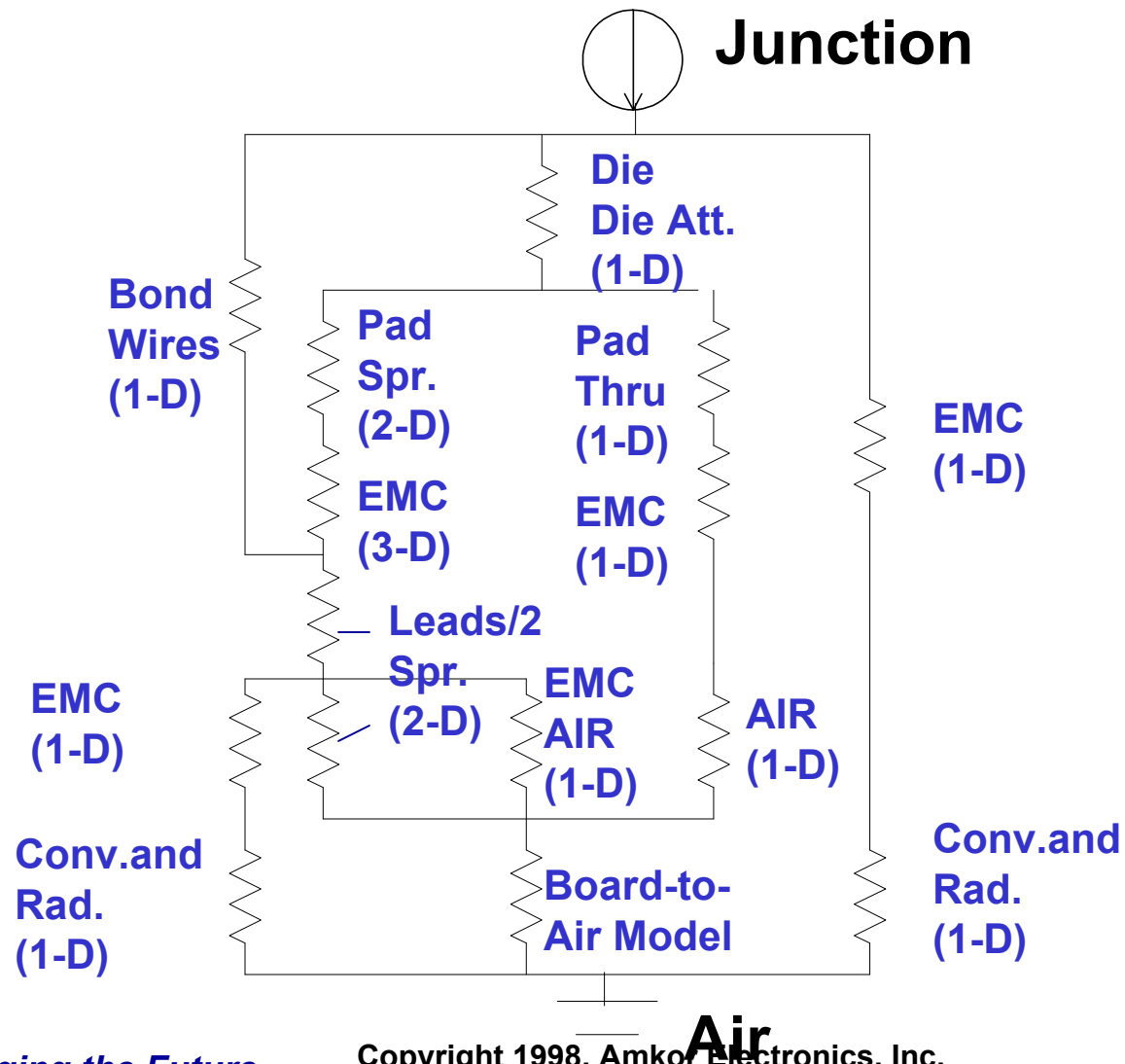
Solution Productivity



34 SBGA package designs analyzed in under 2 hours

- Natural convection
- $\Delta T_{JA} = 60^{\circ}\text{C}$
- Multilayer test board

Thermal Circuit Diagram for MQFP Package

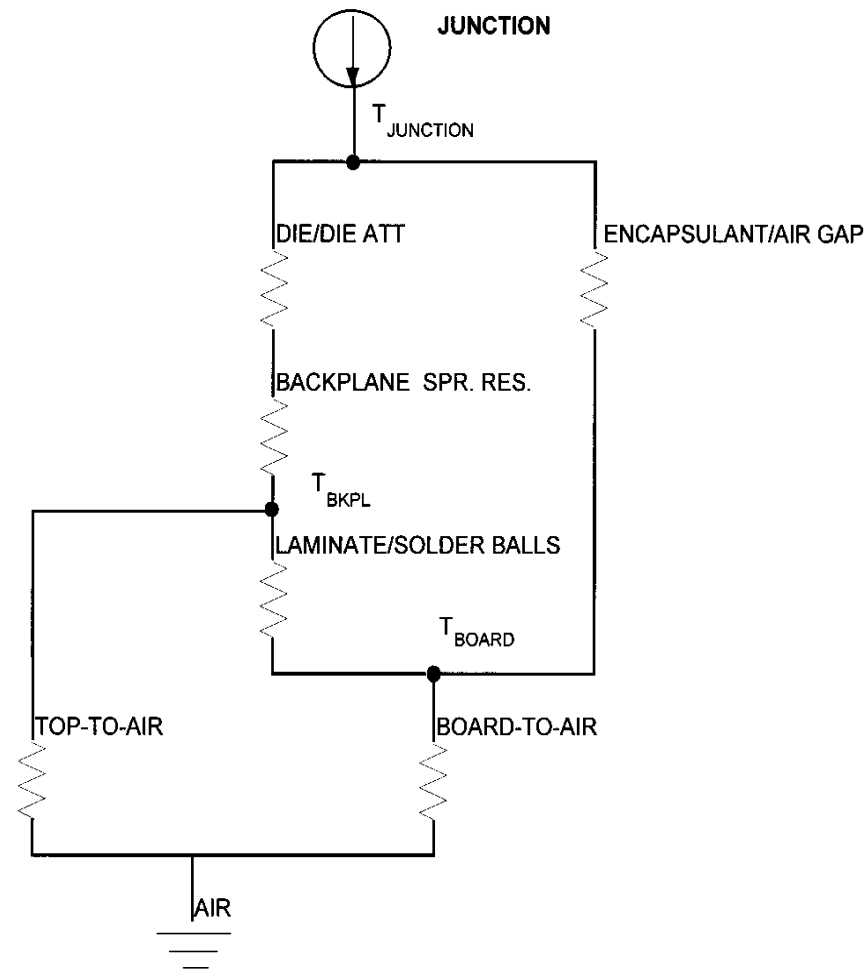


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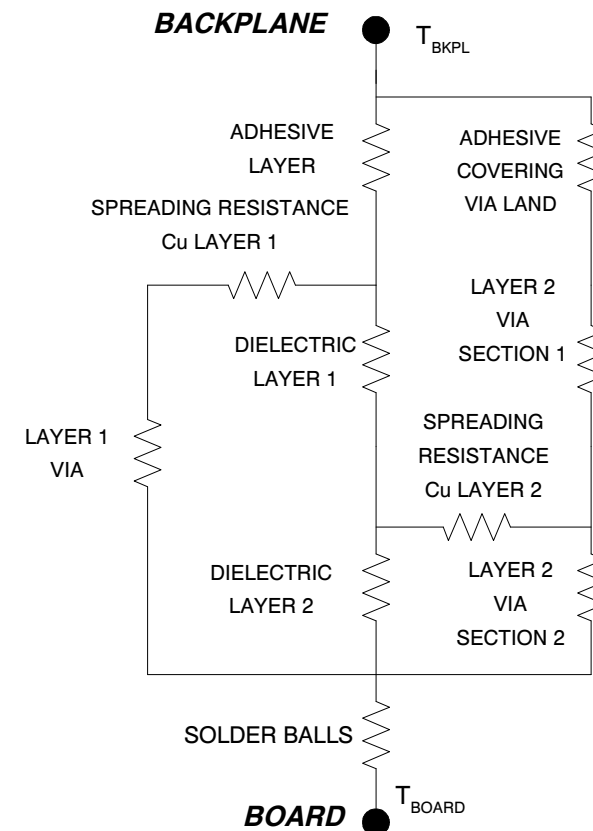
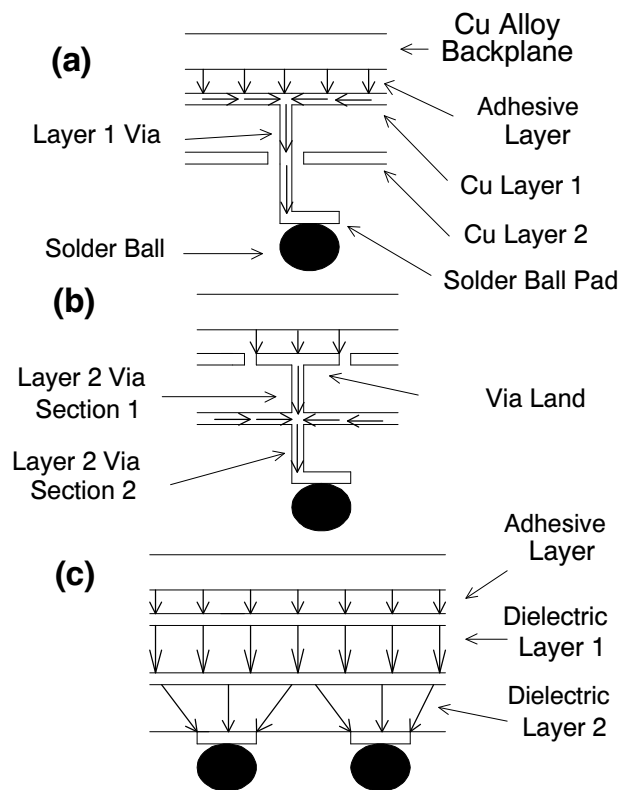
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Thermal Resistor Network for SBGA Package



Submodel to Calculate Thermal Resistance of Laminate



Solution of Thermal Resistance Network

Use successive approximations technique to solve for

- Temperatures on all surfaces with temperature-dependent heat transfer coefficients
- Simplify resistance networks by eliminating current loops: solution of equivalent resistors
- Size of thermal footprint of package (PBGA package)



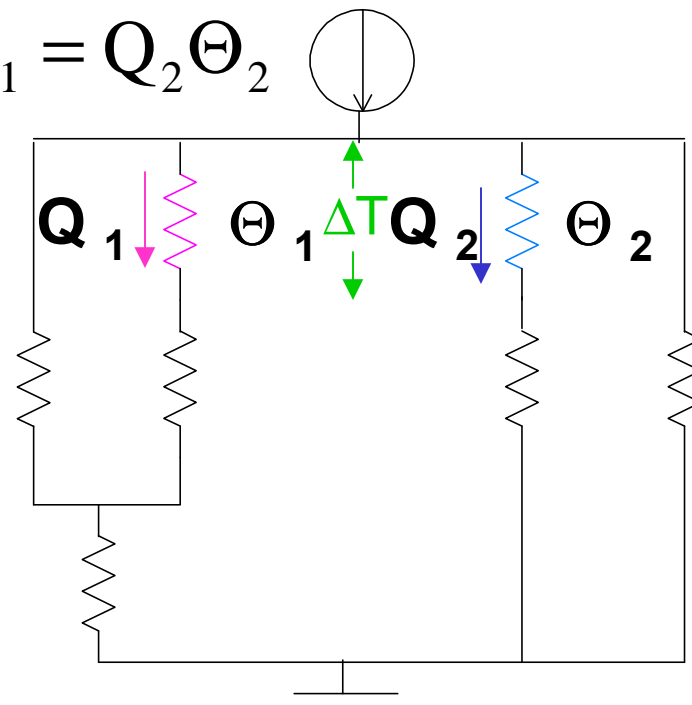
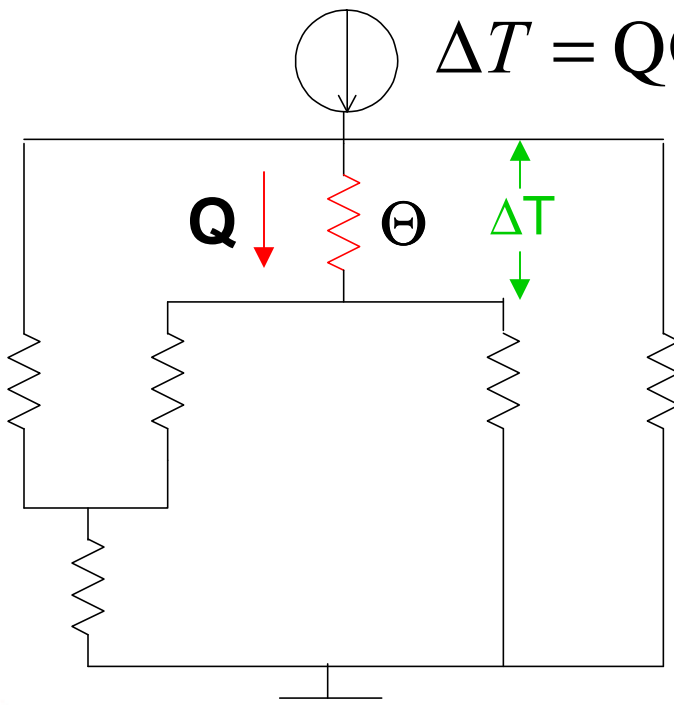
Elimination of Current Loops

To simplify circuit into simple series and parallel resistor networks

Iterate f until ΔT across R_1 and R_2 is the same as across R

$$Q = Q_1 + Q_2 \quad Q_1 = fQ, \quad Q_2 = (1-f)Q$$

$$\Delta T = Q\Theta = Q_1\Theta_1 = Q_2\Theta_2$$



Structure of Spreadsheet

Package component list, materials, and dimensions -- given range name:\$tbl_inputs

Therm. cond. values from @vlookup link to separate file

**Outputs: Θ_{JA} , Θ_{JC} ,
board conductivity,
heat transfer
coefficient**

Package parameters

Application-specific inputs: board type, power, air velocity,...

[illegible]

Example of Thermal Resistance Calculation: Circular Fin

G	A	B	C	D	E	F	G
1							
2		INPUTS				LOCAL	
3		Components				OUTPUTS	
4		COMPONENT	Type	THICKNESS	TH.COND.		
5				(mm)	(w/mm-°C)		
6		Board	ALYR 1S 1 20 2P 1 100	1.57	2.50E-02		
7							
8		COMPONENT	WIDTH			R,equiv	
9			(mm)			(mm)	
10		Package Body	28			15.80	
11							
12		COMPONENT	WIDTH			R,equiv	
13			(mm)			(mm)	
14		Board	50			28.21	
15							
16		Environmental					
17		h					
18		(W/mm^2-K)					
19		2.00E-05					
20							
21		LOCAL OUTPUTS					
22		Parameter				Value	Units
23		alpha				0.032	
24		K,1(alpha b)*I,0(alpha a) + I,1(alpha b)*K,0(alpha a)				1.22	
25		I,1(alpha a)*K,1(alpha b) - I,1(alpha b)*K,1(alpha a)				-0.63	
26		1/(2 pi a t k alpha)				8.04	(°C/W)
27		GLOBAL OUTPUTS					
28		Theta,board-to-air				15.58	(°C/W)

Value of Width obtained by linking to table on input page thru special function:

@XINDEX(\$TBL_INPUTS, C12,\$B10)

**+@BESSELK(F23*F14,1)
* @BESSELI(F23*F10,0)+
@BESSELI(F23*F14,1)*
@BESSELK(F23*F10,0)**



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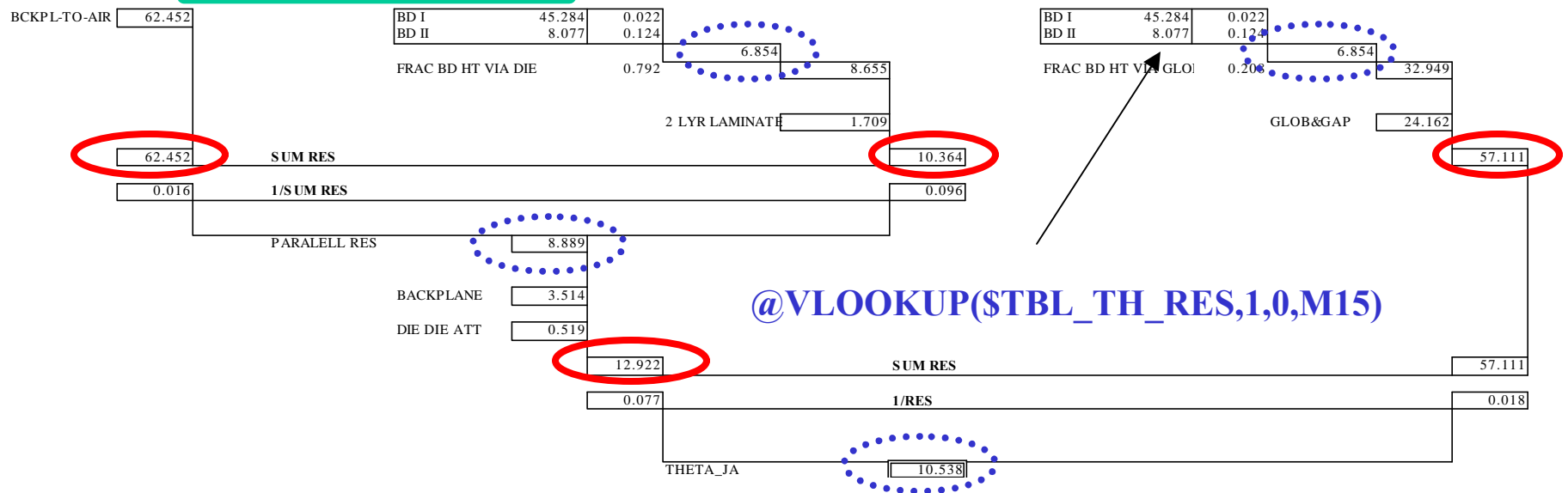
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Spreadsheet Solution of Resistance Network

0 LAMINATE	3.64
1 BACKPLANE	3.51
2 WIRES_TRACES	N/A
3 GLOB&GAP	24.16
4 DIE DIE ATT	0.52
5 BD I	45.28
6 BD II	8.08
7 BCKPL-TO-AIR	62.45
8 2 LYR LAMINATE	1.71
FRAC_HT_BD	0.88

Lookup table linked to solutions of individual resistors, each on separate pages -- named \$TBL_TH_RES



= Series Resistor Solution

= Parallel Resistor Solution



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Example of Macros to Solve Non-Linear Resistor Network

MACRO: /ITER_LOOP	START	STOP	STEP	COUNTER
{FOR \$J\$6,1,50,1,/LOOP}	1	50	1 /LOOP	9

MACRO: /LOOP	START	STOP	STEP	COUNTER
{IF MAX_ERROR<0.1}{RETURN}				
{FOR \$J\$11,1,5,1,/ITER_T_DIE}	1	5	1 /ITER_T_DIE	1
{FOR \$J\$12,1,5,1,/ITER_T_BOARD}	1	5	1 /ITER_T_BOARD	1
{FOR \$J\$13,1,5,1,/ITER_FRAC_DIE}	1	5	1 /ITER_FRAC_DIE	1
{FOR \$J\$14,1,5,1,/ITER_FRAC_BD}	1	5	1 /ITER_FRAC_BD	1

MACRO: /ITER_T_DIE	
{LET \$T_BKPL_TRIAL,63.1744}	\$T_BKPL_\$DEL_T_B <input type="text" value="25"/>
{CALC}	
{IF 0.0459<0.100}{FORBREAK}	\$DEL_T_B <input type="text" value="0.1"/>
{RETURN}	

MACRO: /ITER_T_BOARD	
{LET \$T_BOARD_TRIAL,56.7619}	\$T_BOARD\$DEL_T_B <input type="text" value="25"/>
{CALC}	
{IF 0.0336<0.100}{FORBREAK}	\$DEL_T_B <input type="text" value="0.1"/>
{RETURN}	

MACRO: /ITER_FRAC_DIE	
{LET FRAC_DIE,0.8162}	FRAC_DIE \$DEL_T_J <input type="text" value="5000"/>
{CALC}	
{IF 0.2463<0.100}{FORBREAK}	\$DEL_T_J <input type="text" value="0.1"/>
{RETURN}	

MACRO: /ITER_FRAC_BD	
{LET FRAC_DIE_HT_BD,0.8573}	FRAC_DIE_\$DEL_T_B <input type="text" value="2500"/>
{CALC}	
{IF 0.1156<0.100}{FORBREAK}	\$DEL_T_B <input type="text" value="0.1"/>
{RETURN}	



Example of Solved Resistor Network: SBGA® Package

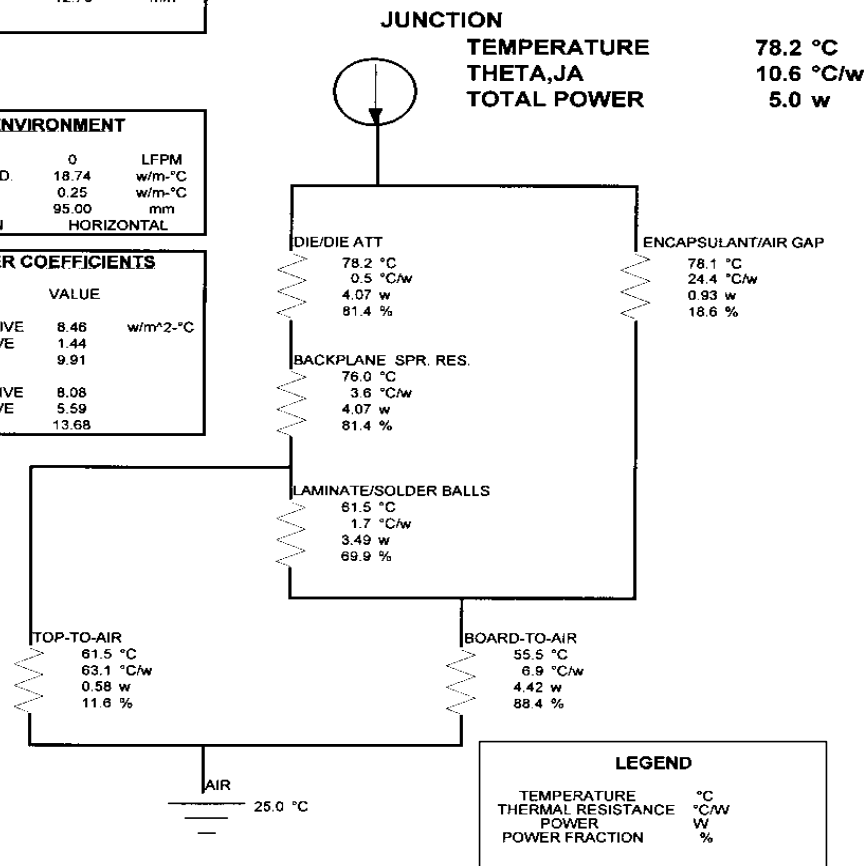
THERMAL RESISTANCE NETWORK FOR 432 LEAD SBGA PACKAGE

PACKAGE PARAMETERS			
WIDTH	40	mm	
ROW COUNT	4		
BALL PITCH	1.27	mm	
BALL MATRIX	31x31		
CAVITY SIZE	14.00	mm	
DIE WIDTH	12.70	mm	

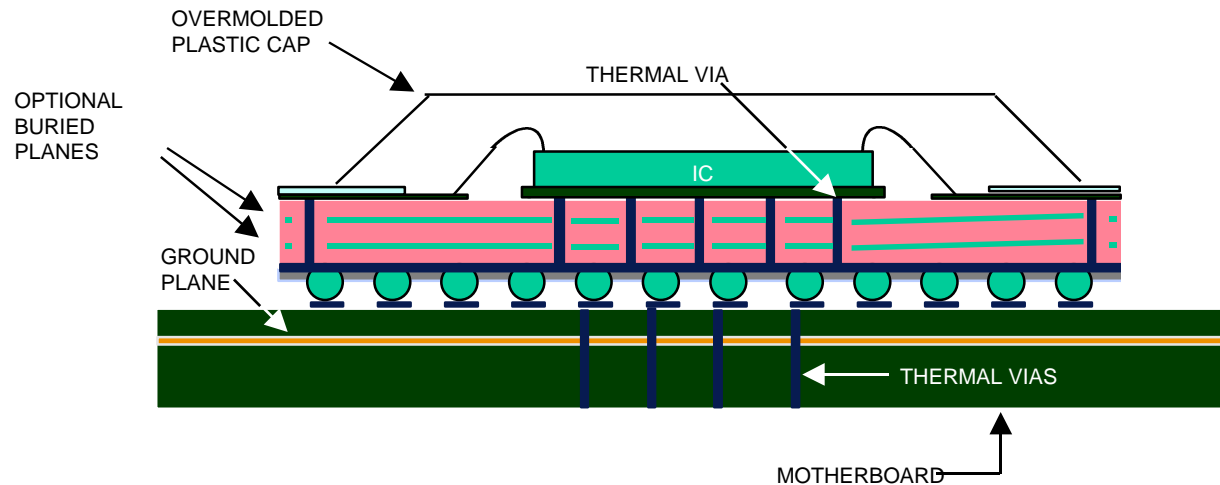
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Advanced Product Development
08-Aug-97

PACKAGE ENVIRONMENT			
AIR VELOCITY	0	LFPM	
IN-PLANE BOARD COND.	18.74	w/m ² ·°C	
THRU BOARD COND.	0.25	w/m ² ·°C	
BOARD WIDTH	95.00	mm	
BOARD ORIENTATION	HORIZONTAL		

HEAT TRANSFER COEFFICIENTS			
SURFACE	TYPE	VALUE	
PKG. TOP	CONVECTIVE	8.46	w/m ² ·°C
	RADIATIVE	1.44	
	TOTAL	9.91	
BOARD	CONVECTIVE	8.08	
	RADIATIVE	5.59	
	TOTAL	13.68	

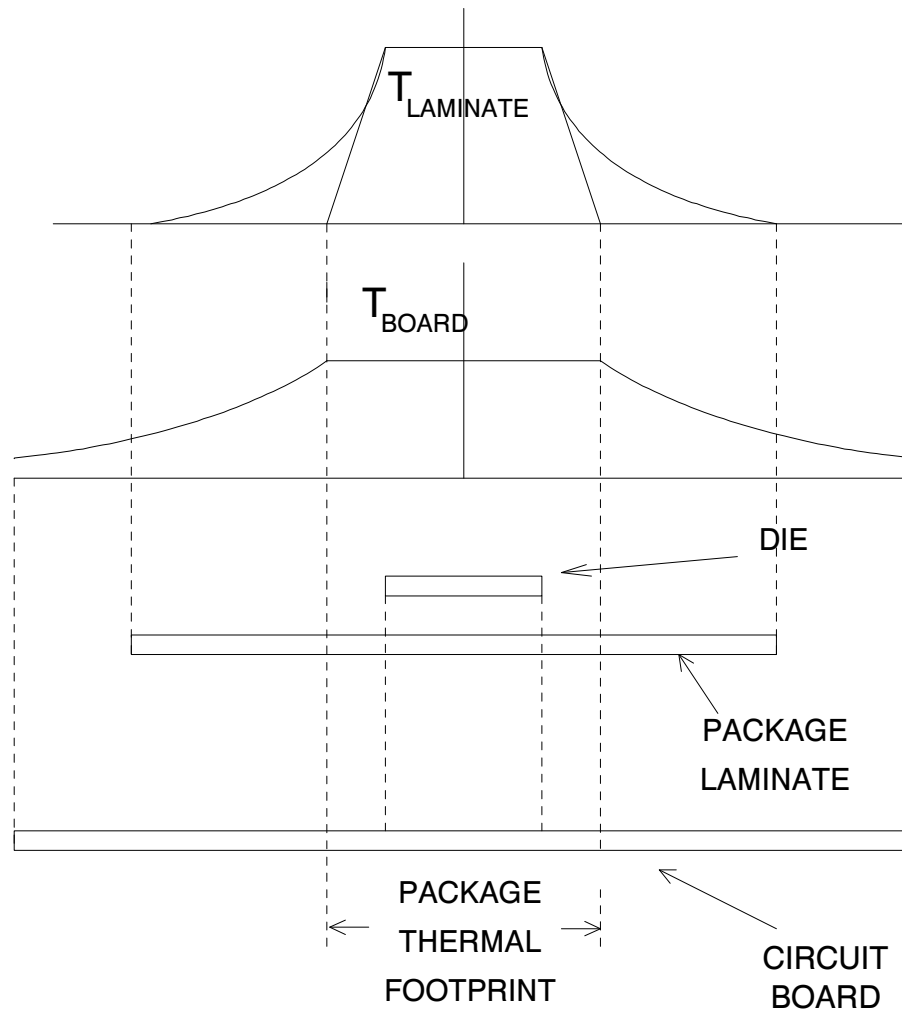


Another Example -- PBGA Package



Reference: B. M. Guenin, B. S. Lall, R. J. Molnar, and R. C. Marrs, "A Study of the Thermal Performance of BGA Packages," *Proceedings, International Flip Chip, Ball Grid Array, TAB, and Advanced Packaging Symposium*, February, 1995, pp 37-46.

PBGA Temperature Distribution



Size of Package Thermal Footprint Determined by Competition Between Heat Spreading and Heat Extraction

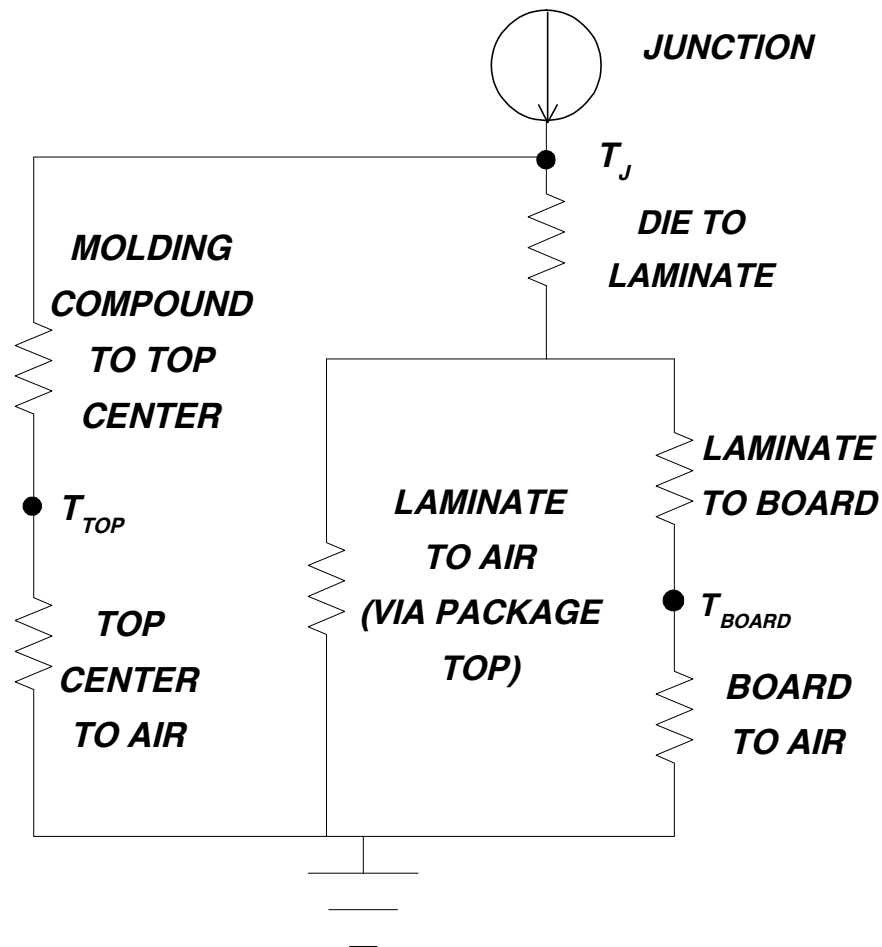


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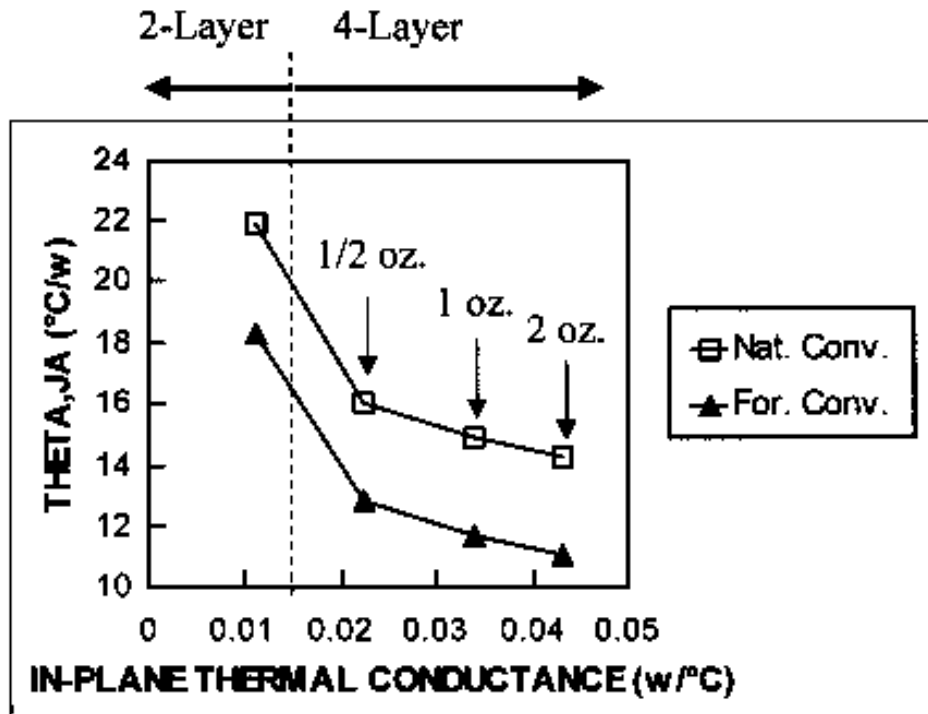
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Thermal Resistance Network for PBGA Package



Effect of Laminate Metal Content



Model Assumptions:

313 Lead, 35 mm PBGA Pkg.

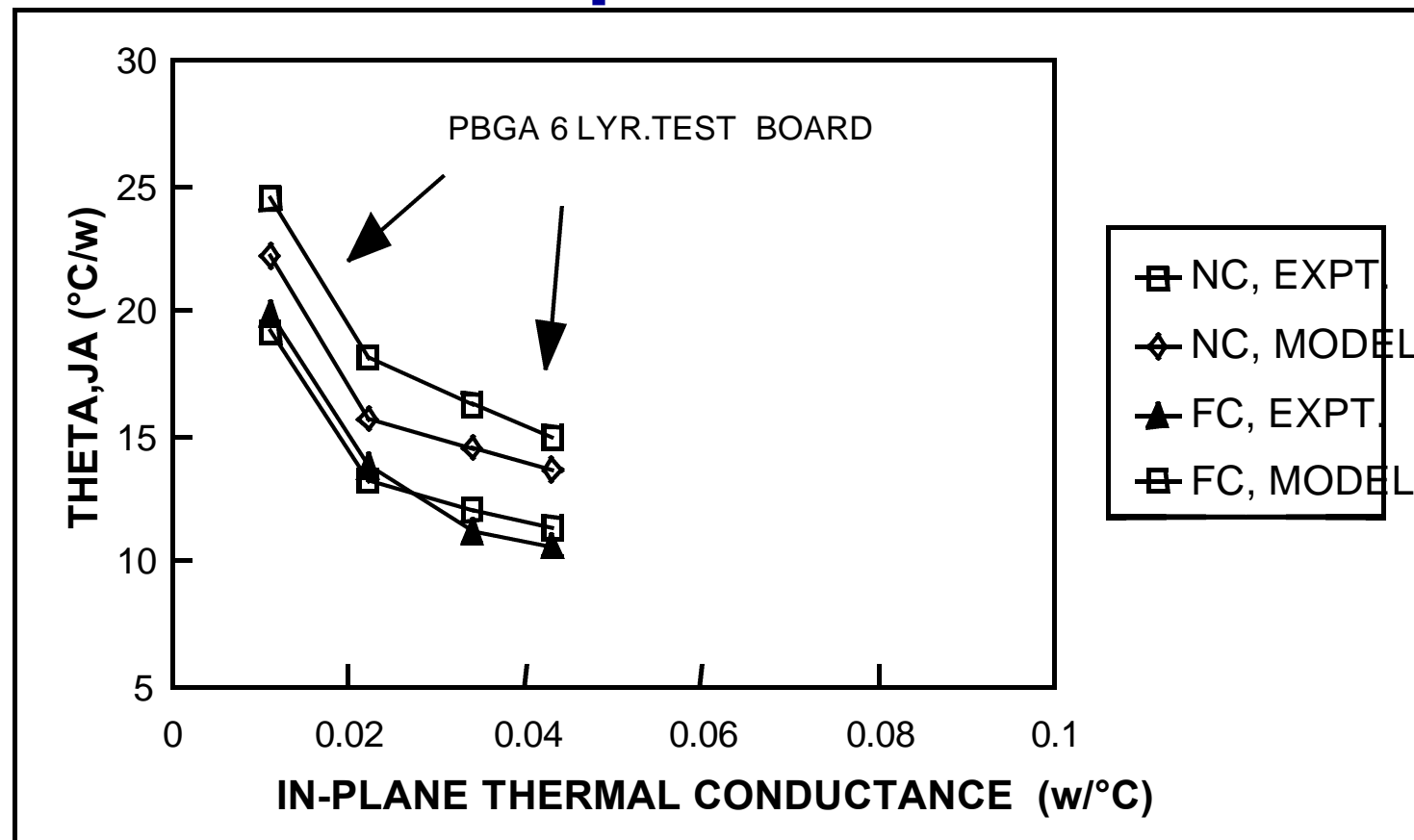
Full Matrix Array

Natural Convection: 4 watt

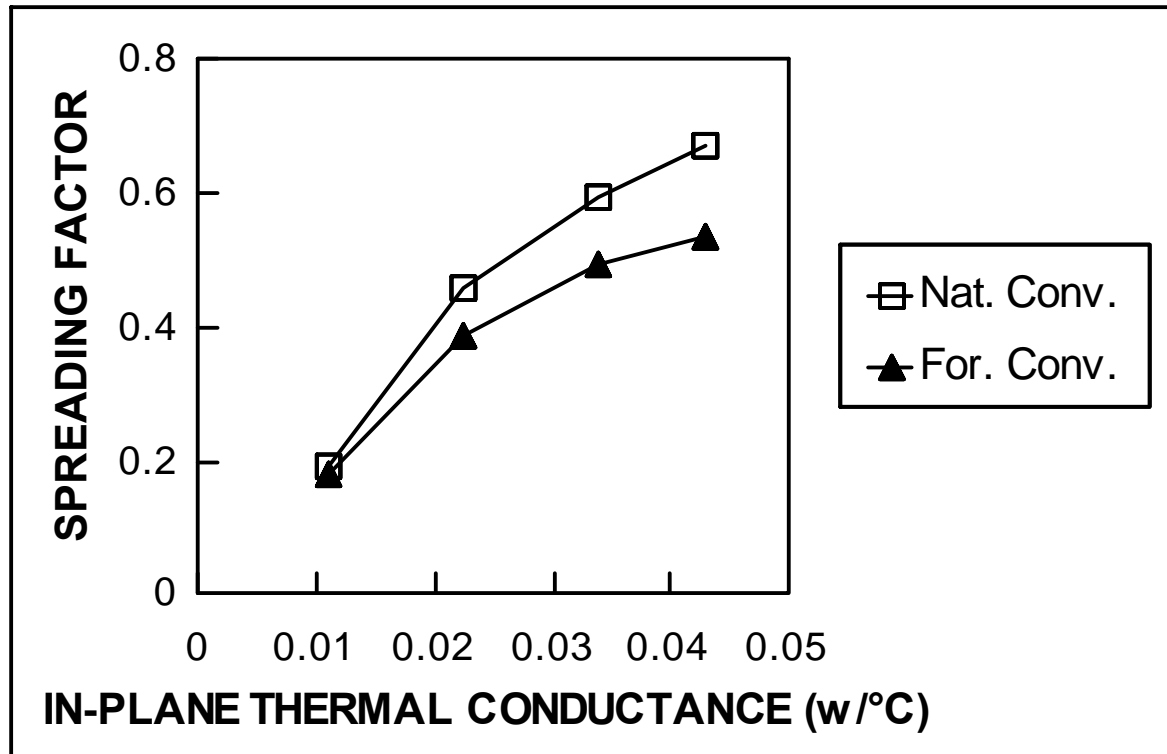
Forced Convection: 2.5 m/s

6-Layer Board, 80 mm width

PBGA Model -- Comparison with Experiment



Effect of Laminate Metal Content



Model Assumptions:

313 Lead, 35 mm PBGA Pkg.

Full Matrix Array

Natural Convection: 4 watt

Forced Convection: 2.5 m/s

6-Layer Board, 80 mm width

$$\text{Spreading Factor} = \frac{W_{\text{FOOTPRINT}} - W_{\text{DIE}}}{W_{\text{PKG}} - W_{\text{DIE}}}$$



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Tradeoffs in Modeling Approaches

Analytical conduction models can adequately predict package thermal performance in simple configurations.

When a package design follows a fixed format, analytical models can be very efficient, justifying the time to develop.

When there are frequent variations in package design, the use of a finite element analysis code is more practical than an analytical approach.

For complicated configurations, dominated by convective heat transfer, a computational fluid dynamics code is most efficient.



Summary

Conduction in leadframe and BGA plastic packages can be described in terms of simple thermal resistive elements, calculated analytically

Convective and radiative heat transfer in a standard thermal test environment can be accounted for using simple analytical expressions

Resistor networks lend themselves to efficient solution of non-linear problems and to rationalizing the thermal performance of a package

Spreadsheets are efficient tools for solving analytical thermal resistance networks

